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2N5196/5197/5198/5199

Vishay Siliconix

Monolithic N-Channel JFET Duals

PRODUCT SUMMARY

Part Number	$V_{GS(off)}$ (V)	$V_{(BR)GSS}$ Min (V)	g_{fs} Min (mS)	I_G Max (pA)	$ V_{GS1} - V_{GS2} $ Max (mV)
2N5196	-0.7 to -4	-50	1	-15	5
2N5197	-0.7 to -4	-50	1	-15	5
2N5198	-0.7 to -4	-50	1	-15	10
2N5199	-0.7 to -4	-50	1	-15	15

FEATURES

- Monolithic Design
- High Slew Rate
- Low Offset/Drift Voltage
- Low Gate Leakage: 5 pA
- Low Noise
- High CMRR: 100 dB

BENEFITS

- Tight Differential Match vs. Current
- Improved Op Amp Speed, Settling Time Accuracy
- Minimum Input Error/Trimming Requirement
- Insignificant Signal Loss/Error Voltage
- High System Sensitivity
- Minimum Error with Large Input Signal

APPLICATIONS

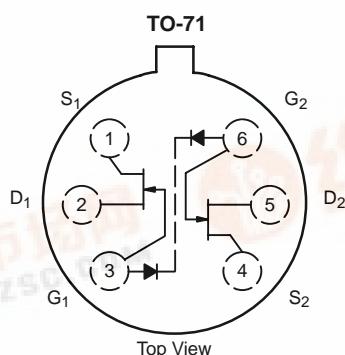
- Wideband Differential Amps
- High-Speed, Temp-Compensated, Single-Ended Input Amps
- High Speed Comparators
- Impedance Converters

DESCRIPTION

The 2N5196/5197/5198/5199 JFET duals are designed for high-performance differential amplification for a wide range of precision test instrumentation applications. This series features tightly matched specs, low gate leakage for accuracy, and wide dynamic range with I_G guaranteed at $V_{DG} = 20$ V.

The hermetically-sealed TO-71 package is available with full military processing (see Military Information and the 2N5545/5546/5547JANTX/JANTXV data sheet).

For similar products see the low-noise U/SST401 series, the high-gain 2N5911/5912, and the low-leakage U421/423 data sheets.



ABSOLUTE MAXIMUM RATINGS

Gate-Drain, Gate-Source Voltage	-50 V
Gate Current	50 mA
Lead Temperature ($\frac{1}{16}$ " from case for 10 sec.)	300 °C
Storage Temperature	-65 to 200 °C
Operating Junction Temperature	-55 to 150 °C

Power Dissipation :	Per Side ^a	250 mW
	Total ^b	500 mW

Notes

- a. Derate 2 mW/°C above 85°C
- b. Derate 4 mW/°C above 85°C

2N5196/5197/5198/5199

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SPECIFICATIONS FOR 2N5196 AND 2N5197 ($T_A = 25^\circ C$ UNLESS OTHERWISE NOTED)

Parameter	Symbol	Test Conditions	Typ ^a	Limits				Unit	
				2N5196		2N5197			
				Min	Max	Min	Max		
Static									
Gate-Source Breakdown Voltage	$V_{(BR)GSS}$	$I_G = -1 \mu A, V_{DS} = 0 V$	-57	-50		-50		V	
Gate-Source Cutoff Voltage	$V_{GS(\text{off})}$	$V_{DS} = 20 V, I_D = 1 nA$	-2	-0.7	-4	-0.7	-4		
Saturation Drain Current ^b	I_{DSS}	$V_{DS} = 20 V, V_{GS} = 0 V$	3	0.7	7	0.7	7	mA	
Gate Reverse Current	I_{GSS}	$V_{GS} = -30 V, V_{DS} = 0 V$ $T_A = 150^\circ C$	-10 -20		-25 -50		-25 -50	pA nA	
Gate Operating Current	I_G	$V_{DG} = 20 V, I_D = 200 \mu A$ $T_A = 125^\circ C$	-5 -0.8		-15 -15		-15 -15	pA nA	
Gate-Source Voltage	V_{GS}	$V_{DG} = 20 V, I_D = 200 \mu A$	-1.5	-0.2	-3.8	-0.2	-3.8	V	
Dynamic									
Common-Source Forward Transconductance	g_{fs}	$V_{DS} = 20 V, V_{GS} = 0 V$ $f = 1 kHz$	2.5	1	4	1	4	mS	
Common-Source Output Conductance	g_{os}		2		50		50	μS	
Common-Source Forward Transconductance	g_{fs}	$V_{DS} = 20 V, I_D = 200 \mu A$ $f = 1 kHz$	0.8	0.7	1.6	0.7	1.6	mS	
Common-Source Output Conductance	g_{os}		1		4		4	μS	
Common-Source Input Capacitance	C_{iss}	$V_{DS} = 20 V, V_{GS} = 0 V$ $f = 1 MHz$	3		6		6	pF	
Common-Source Reverse Transfer Capacitance	C_{rss}		1		2		2		
Equivalent Input Noise Voltage	\bar{e}_n	$V_{DS} = 20 V, V_{GS} = 0 V, f = 1 kHz$	9		20		20	nV/√Hz	
Noise Figure	NF	$V_{DS} = 20 V, V_{GS} = 0 V$ $f = 100 Hz, R_G = 10 M\Omega$			0.5		0.5	dB	
Matching									
Differential Gate-Source Voltage	$ V_{GS1}-V_{GS2} $	$V_{DG} = 20 V, I_D = 200 \mu A$			5		5	mV	
Gate-Source Voltage Differential Change with Temperature	$\frac{\Delta V_{GS1}-V_{GS2} }{\Delta T}$	$V_{DG} = 20 V, I_D = 200 \mu A$ $T_A = -55 to 125^\circ C$			5		10	μV/°C	
Saturation Drain Current Ratio	$\frac{I_{DSS1}}{I_{DSS2}}$	$V_{DS} = 20 V, V_{GS} = 0 V$	0.98	0.95	1	0.95	1		
Transconductance Ratio	$\frac{g_{fs1}}{g_{fs2}}$	$V_{DS} = 20 V, I_D = 200 \mu A$ $f = 1 kHz$	0.99	0.97	1	0.97	1		
Differential Output Conductance	$ g_{os1}-g_{os2} $		0.1		1		1	μS	
Differential Gate Current	$ I_{G1}-I_{G2} $	$V_{DG} = 20 V, I_D = 200 \mu A, T_A = 125^\circ C$	0.1		5		5	nA	
Common Mode Rejection Ratio ^c	CMRR	$V_{DG} = 10 to 20 V, I_D = 200 \mu A$	100					dB	



2N5196/5197/5198/5199

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SPECIFICATIONS FOR 2N5198 AND 2N5199 ($T_A = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)

Parameter	Symbol	Test Conditions	Typ ^a	Limits				Unit	
				2N5198		2N5199			
				Min	Max	Min	Max		
Static									
Gate-Source Breakdown Voltage	$V_{(\text{BR})\text{GSS}}$	$I_G = -1 \mu\text{A}, V_{DS} = 0 \text{ V}$	-57	-50		-50		V	
Gate-Source Cutoff Voltage	$V_{GS(\text{off})}$	$V_{DS} = 20 \text{ V}, I_D = 1 \text{ nA}$	-2	-0.7	-4	-0.7	-4		
Saturation Drain Current ^b	I_{DSS}	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}$	3	0.7	7	0.7	7	mA	
Gate Reverse Current	I_{GSS}	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$ $T_A = 150^\circ\text{C}$	-10 -20		-25 -50		-25 -50	pA nA	
Gate Operating Current	I_G	$V_{DG} = 20 \text{ V}, I_D = 200 \mu\text{A}$ $T_A = 125^\circ\text{C}$	-5 -0.8		-15 -15		-15 -15	pA nA	
Gate-Source Voltage	V_{GS}	$V_{DG} = 20 \text{ V}, I_D = 200 \mu\text{A}$	-1.5	-0.2	-3.8	-0.2	-3.8	V	
Dynamic									
Common-Source Forward Transconductance	g_{fs}	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ kHz}$	2.5	1	4	1	4	mS	
Common-Source Output Conductance	g_{os}		2		50		50	μS	
Common-Source Forward Transconductance	g_{fs}	$V_{DS} = 20 \text{ V}, I_D = 200 \mu\text{A}$ $f = 1 \text{ kHz}$	0.8	0.7	1.6	0.7	1.6	mS	
Common-Source Output Conductance	g_{os}		1		4		4	μS	
Common-Source Input Capacitance	C_{iss}	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	3		6		6	pF	
Common-Source Reverse Transfer Capacitance	C_{rss}		1		2		2		
Equivalent Input Noise Voltage	\bar{e}_n	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ kHz}$	9		20		20	$\frac{\text{nV}}{\sqrt{\text{Hz}}}$	
Noise Figure	NF	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}$ $f = 100 \text{ Hz}, R_G = 10 \text{ M}\Omega$			0.5		0.5	dB	
Matching									
Differential Gate-Source Voltage	$ V_{GS1} - V_{GS2} $	$V_{DG} = 20 \text{ V}, I_D = 200 \mu\text{A}$			10		15	mV	
Gate-Source Voltage Differential Change with Temperature	$\frac{\Delta V_{GS1} - V_{GS2} }{\Delta T}$	$V_{DG} = 20 \text{ V}, I_D = 200 \mu\text{A}$ $T_A = -55 \text{ to } 125^\circ\text{C}$			20		40	$\mu\text{V}/^\circ\text{C}$	
Saturation Drain Current Ratio	$\frac{I_{DSS1}}{I_{DSS2}}$	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}$	0.97	0.95	1	0.95	1		
Transconductance Ratio	$\frac{g_{fs1}}{g_{fs2}}$	$V_{DS} = 20 \text{ V}, I_D = 200 \mu\text{A}$ $f = 1 \text{ kHz}$	0.97	0.95	1	0.95	1		
Differential Output Conductance	$ g_{os1} - g_{os2} $		0.2		1		1	μS	
Differential Gate Current	$ I_{G1} - I_{G2} $	$V_{DG} = 20 \text{ V}, I_D = 200 \mu\text{A}, T_A = 125^\circ\text{C}$	0.1		5		5	nA	
Common Mode Rejection Ratio ^c	CMRR	$V_{DG} = 10 \text{ to } 20 \text{ V}, I_D = 200 \mu\text{A}$	97					dB	

Notes

- a. Typical values are for DESIGN AID ONLY, not guaranteed nor subject to production testing.
- b. Pulse test: PW ≤ 300 μs duty cycle ≤ 3%.
- c. This parameter not registered with JEDEC.

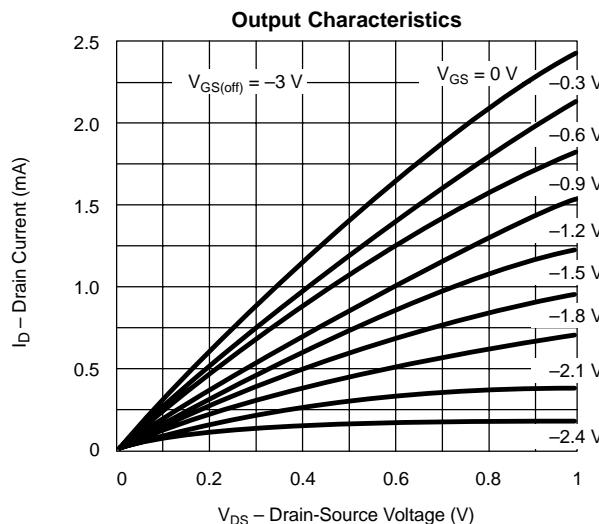
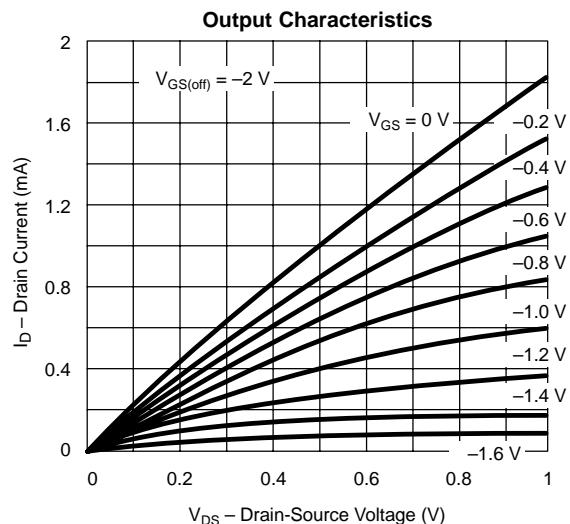
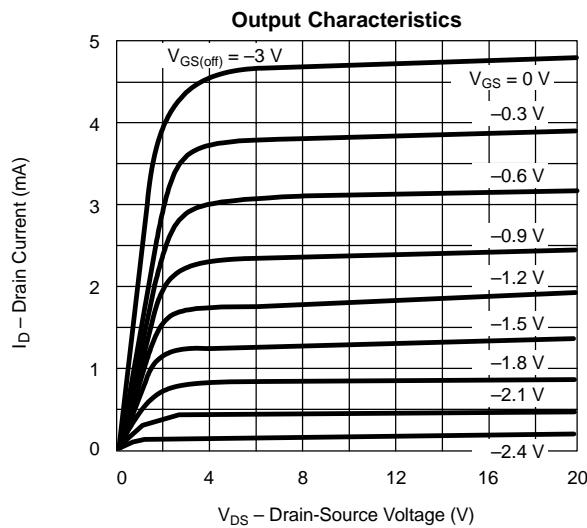
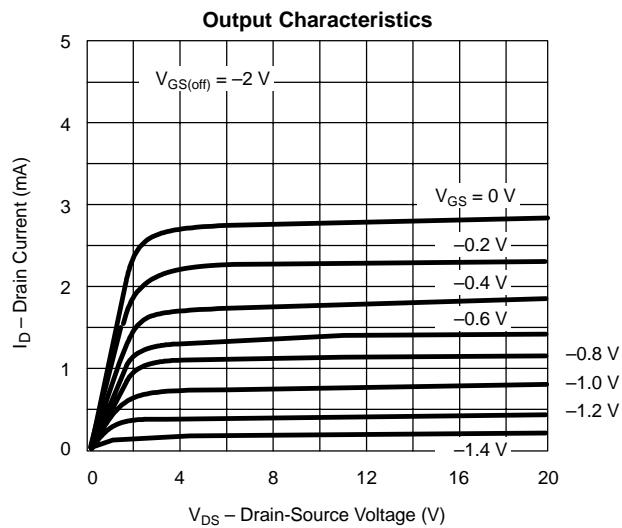
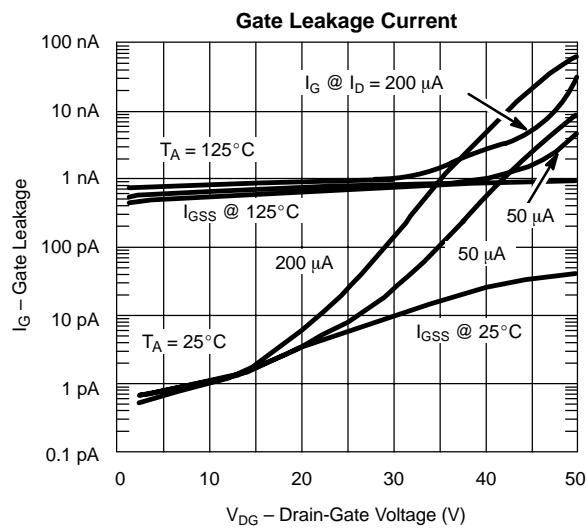
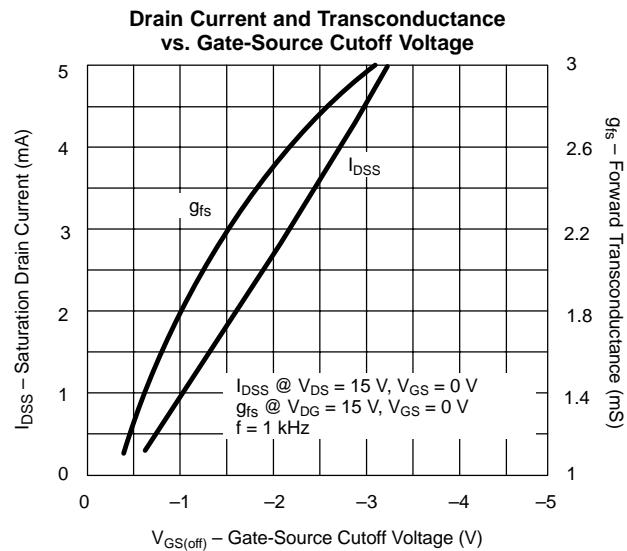
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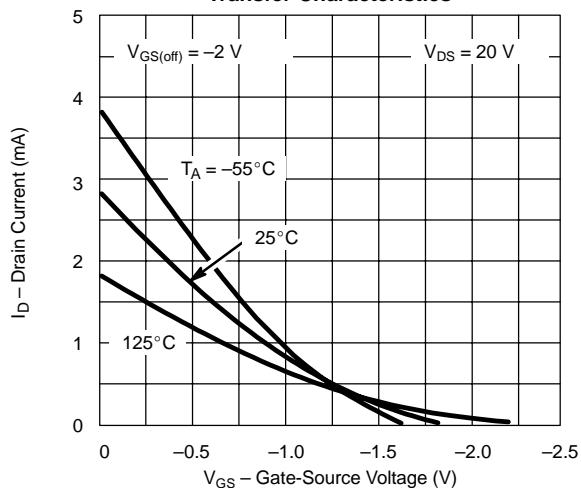
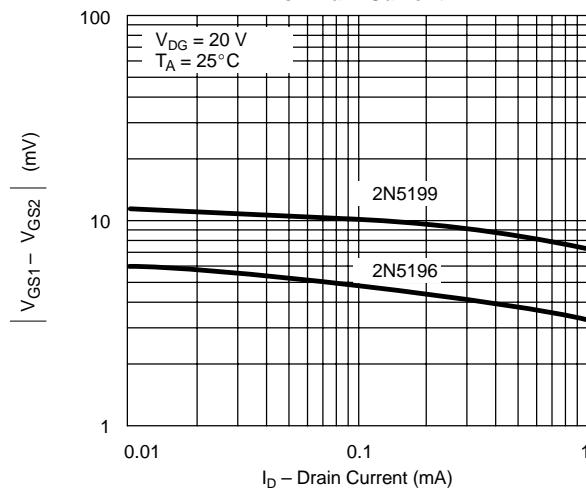
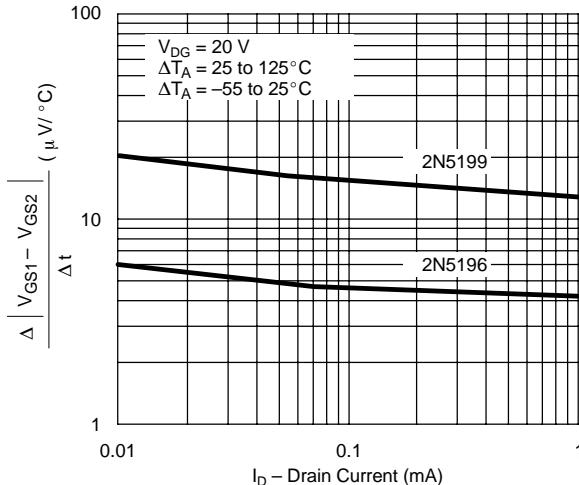
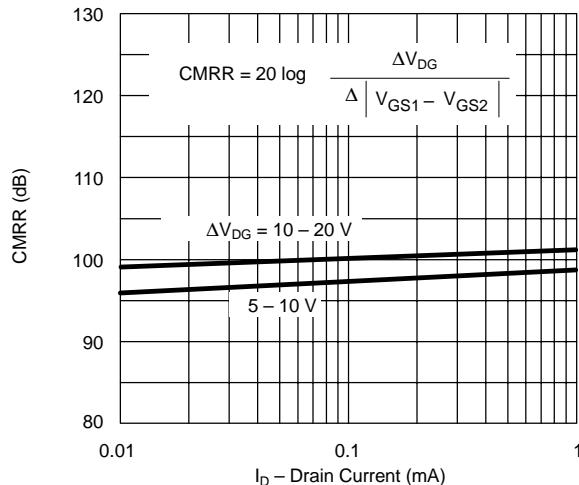
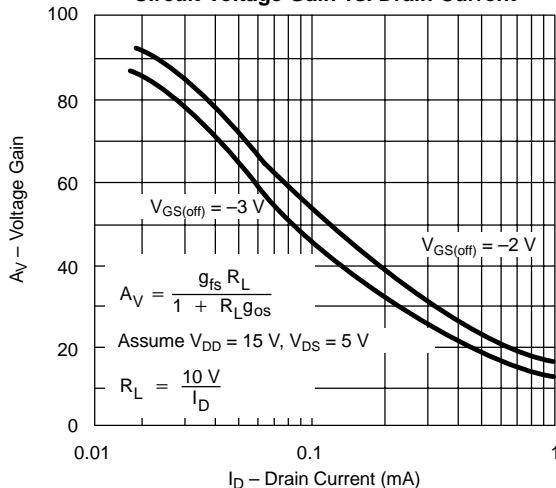
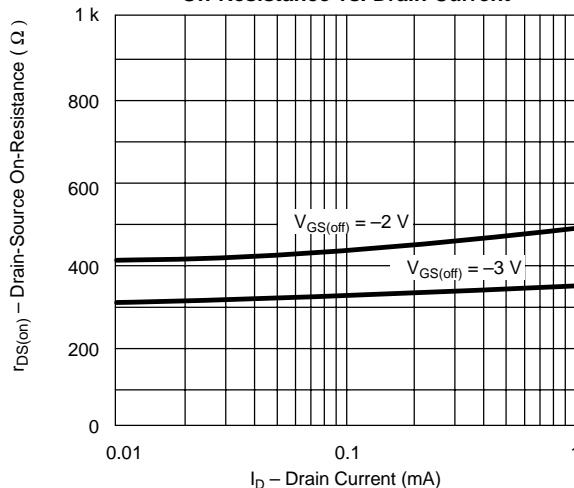
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TYPICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)



TYPICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)
Transfer Characteristics

Gate-Source Differential Voltage vs. Drain Current

Voltage Differential with Temperature vs. Drain Current

Common Mode Rejection Ratio vs. Drain Current

Circuit Voltage Gain vs. Drain Current

On-Resistance vs. Drain Current


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TYPICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)

